Docket No.: SHIGA7.037APC

## INFORMATION DISCLOSURE STATEMENT 09 DEC 2005

Applicant

Tamura et al.

App. No

Unknown

Filed

Herewith

For

POSITIVE RESIST COMPOSITION,

RESIST LAMINATES AND PROCESS

FOR FORMING RESIST PATTERNS

Examiner

Unknown

Art Unit

Unknown

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## Dear Sir:

Enclosed for filing in the above-identified application is a PTO/SB/08 Equivalent listing 21 references to be considered by the Examiner. Also enclosed are 16 foreign patent references and/or non-patent literature as listed on the Information Disclosure Statement. Please note that U.S. 5,399,462 is the counterpart to JP 6-202338; U.S. 5,612,170 is the counterpart to JP 8-160620; US 5,691,396 is the counterpart to JP 9-87391; US 2002/0025495 A1 is the counterpart to JP 2002-55452; US 2003/0219676 A1 is the counterpart to WO 2004/05598 A1. Please also note that reference numbers 4-5 and 10-20 are cited in the International Search Report from PCT priority application Serial No. PCT/JP2004/008282.

This Information Disclosure Statement is being filed within three months of the filing date, with an RCE or before receipt of a first office action after an RCE and no fee is required.

10/560126

Unknown

**Filed** 

Herewith

Docket No. SHIGA7.037APC

Customer No. 20,995

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The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment, to Account No. 11-1410.

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: 9 Dec. 2005

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PTO/SB/08 Equivalent

1	Application No.	Unknown 0 / 5 60 1 2 6 Herewith 0 / 5 60 1 2 6
INFORMATION DISCLOSURE	Filing Date	Herewith
STATEMENT BY APPLICANT	First Named Inventor	Tamura, Koki
STATEMENT BY AFFLICANT	Art Unit	Unknown
(Multiple sheets used when necessary)	Examiner	Unknown
SHEET 1 OF 1	Attorney Docket No.	SHIGA7.037APC

	U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number Number - Kind Code (if known) Example: 1,234,567 B1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear
	1	5,399,462	03-21-1995	Sachdev et al.	
	2	5,612,170	03-18-1997	Takemura et al.	
· · · · · ·	3	5,691,396	11-25-1997	Takemura et al.	
	4	US 2002/0025495 A1	02-28-2002	Ogata et al.	
	5	US 2003/0219676 A1	11-27-2003	Barclay et al.	

			FOREIGN PATE	ENT DOCUMENTS		
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code Example: JP 1234567 A1	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
	6	JP 6-202338 <sup>J</sup>	07-22-1994	IBM		
-	7	JP 08-029987 €	02-02-1996	Nippon Telegr.		Abstract
	8	JP 8-160620 /	06-21-1996			
	9	JP 9-87391 ′	03-31-1997			-
	10	JP 2001-051422 /	02-23-2001	Tokyo Ohka Kogyo Co. Ltd.		Abstract
	11	WO 02/091083 A1	11-14-2002	Shipley Co., L.L.C.		
	12	JP 08-029986 /	02-02-1996	Hitachi Ltd.		Abstract
	13	JP 2001-265006 /	09-28-2001	TDK Corp.		Abstract
	14	JP 63-101427 /	05-06-1988	Hitachi Ltd.		Abstract
	15	JP 63-090534 /	04-21-1988	Hitachi Ltd.		Abstract
	16	EP 0 204 963 A2 /	12-17-1986	Hitachi Ltd.		· <del></del> ·
	17	JP 62-96526 /	05-06-1987			
	18	JP 2004-38143 /	02-05-2004	Shipley Co., L.L. C.		
	19	WO 2004/05598 A1 /	07-01-2004	Tokyo Ohka Kogyo Co., Ltd.		Abstract
	20	JP 2002-55452 /	02-20-2002			

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>1</sup>
	21	International Search Report from PCT priority application Serial No. PCT/JP 2004/008282.	

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Examiner Signature

**Date Considered** 

<sup>\*</sup>Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.